BLF6G22LS-100

Power LDMOS transistor

Rev. 02 — 31 March 2010 Product data sheet

1. Product profile

1.1 General description

100 W LDMOS power transistor for base station applications at frequencies from 2000 MHz to 2200 MHz.

Table 1. Typical performance

RF performance at T_{case} = 25 °C in a common source class-AB production test circuit.

Mode of operation	f	V_{DS}	$P_{L(AV)}$	G_p	η_D	IMD3	ACPR
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)	(dBc)
2-carrier W-CDMA	2110 to 2170	28	25	18.2	29	–37[1]	–41[1]

[1] Test signal: 3GPP; test model 1; 64 DPCH; PAR = 7 dB at 0.01 % probability on CCDF per carrier; carrier spacing 10 MHz.

CAUTION

This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features and benefits

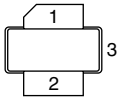
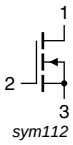
- Typical 2-carrier W-CDMA performance at frequencies of 2110 MHz and 2170 MHz, a supply voltage of 28 V and an I_{Dq} of 950 mA:
  - Average output power = 25 W
  - Gain = 18.2 dB
  - Efficiency = 29 %
  - IMD3 = –37 dBc
  - ACPR = –41 dBc
- Easy power control
- Integrated ESD protection
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (2000 MHz to 2200 MHz)
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

1.3 Applications

- RF power amplifiers for W-CDMA base stations and multi carrier applications in the 2000 MHz to 2200 MHz frequency range

2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	drain		
2	gate		
3	source [1]		

sym112

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BLF6G22LS-100	-	earless flanged LDMOST ceramic package; 2 leads	SOT502B

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	65	V
V_{GS}	gate-source voltage		−0.5	+13	V
I_D	drain current		-	29	A
T_{stg}	storage temperature		−65	+150	°C
T_j	junction temperature		-	225	°C

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j\text{-}case)}$	thermal resistance from junction to case	T_{case} = 80 °C; P_L = 25 W	0.43	K/W

6. Characteristics

Table 6. Characteristics

T_j = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	V_{GS} = 0 V; I_D = 0.5 mA	65	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	V_{DS} = 10 V; I_D = 150 mA	1.4	1.9	2.4	V
V_{GSq}	gate-source quiescent voltage	V_{DS} = 28 V; I_D = 900 mA	1.76	2.26	2.76	V
I_{DSS}	drain leakage current	V_{GS} = 0 V; V_{DS} = 28 V	-	-	5	μA
I_{DSX}	drain cut-off current	V_{GS} = $V_{GS(th)}$ + 3.75 V; V_{DS} = 10 V	22	28	-	A
I_{GSS}	gate leakage current	V_{GS} = 11 V; V_{DS} = 0 V	-	-	450	nA
g_{fs}	forward transconductance	V_{DS} = 10 V; I_D = 7.5 A	-	11	-	S
$R_{DS(on)}$	drain-source on-state resistance	V_{GS} = $V_{GS(th)}$ + 3.75 V; I_D = 5.25 A	-	0.1	0.16	Ω
C_{rs}	feedback capacitance	V_{GS} = 0 V; V_{DS} = 28 V; f = 91 MHz	-	2.1	-	pF

7. Application information

Table 7. Application information

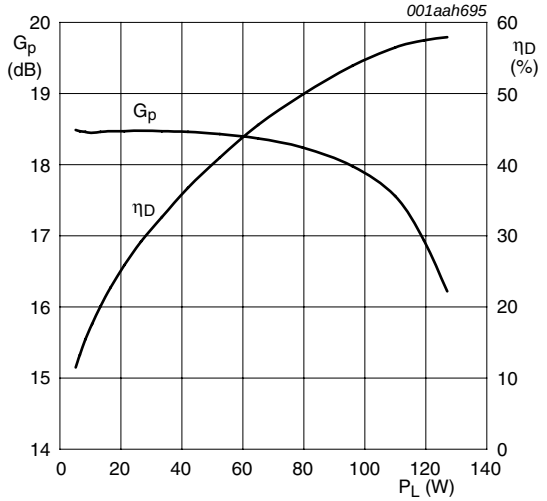
Mode of operation: 2-carrier W-CDMA; PAR 7 dB at 0.01 % probability on CCDF; 3GPP test model 1; 1-64 PDPCH; f_1 = 2112.5 MHz; f_2 = 2122.5 MHz; f_3 = 2157.5 MHz; f_4 = 2167.5 MHz; RF performance at V_{DS} = 28 V; I_{Dq} = 950 mA; T_{case} = 25 °C; unless otherwise specified; in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$P_{L(AV)}$	average output power		-	25	-	W
G_p	power gain	$P_{L(AV)}$ = 25 W	17	18.2	-	dB
IRL	input return loss	$P_{L(AV)}$ = 25 W	-	–9	–7	dB
η_D	drain efficiency	$P_{L(AV)}$ = 25 W	27.5	29	-	%
IMD3	third-order intermodulation distortion	$P_{L(AV)}$ = 25 W	-	–37	–34.5	dBc
ACPR	adjacent channel power ratio	$P_{L(AV)}$ = 25 W	-	–41	–38.5	dBc

7.1 Ruggedness in class-AB operation

The BLF6G22LS-100 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: V_{DS} = 28 V; I_{Dq} = 950 mA; P_L = 100 W (CW); f = 2170 MHz.

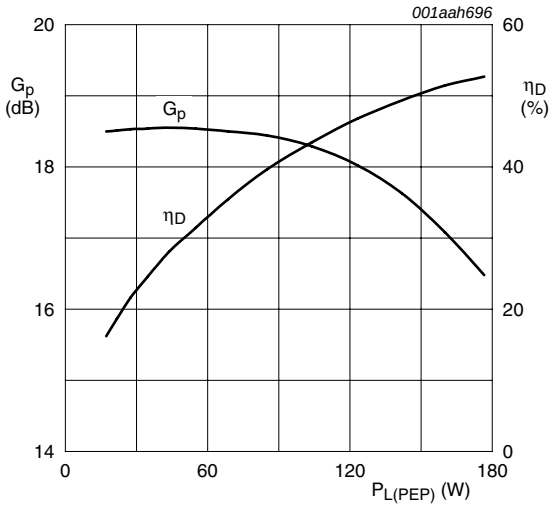
7.2 One-tone CW



V_{DS} = 28 V; I_{Dq} = 950 mA; f = 2140 MHz.

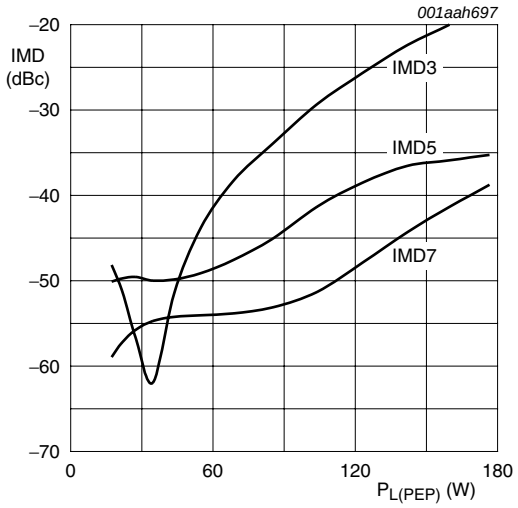
Fig 1. One-tone CW power gain and drain efficiency as functions of load power; typical values

7.3 Two-tone CW



V_{DS} = 28 V; I_{Dq} = 950 mA; f = 2140 MHz (±100 kHz).

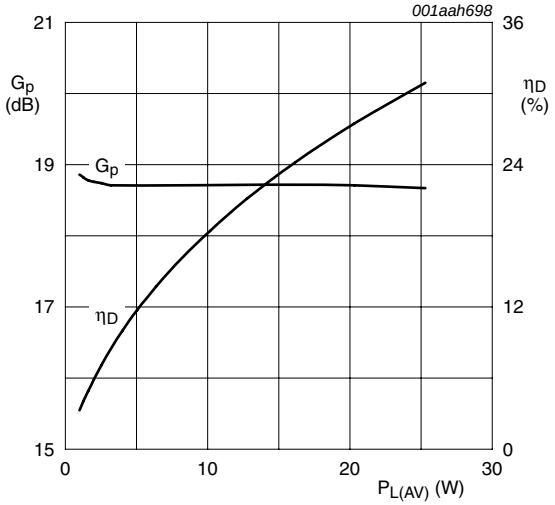
Fig 2. Two-tone CW power gain and drain efficiency as functions of peak envelope load power; typical values



V_{DS} = 28 V; I_{Dq} = 950 mA; f = 2140 MHz (±100 kHz).

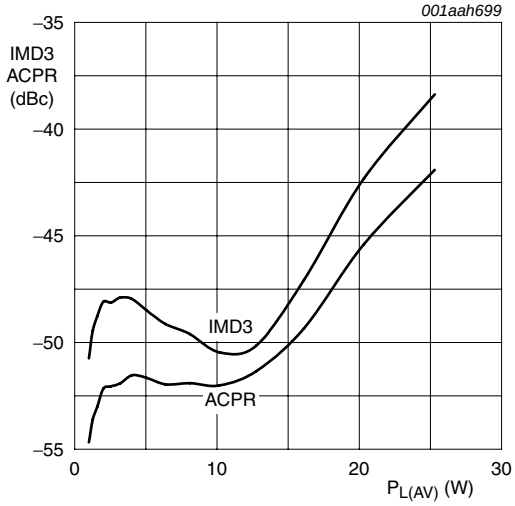
Fig 3. Two-tone CW intermodulation distortion as function of peak envelope load power; typical values

7.4 2-carrier W-CDMA



V_{DS} = 28 V; I_{Dq} = 950 mA; f = 2140 MHz (± 5 MHz); carrier spacing 10 MHz.

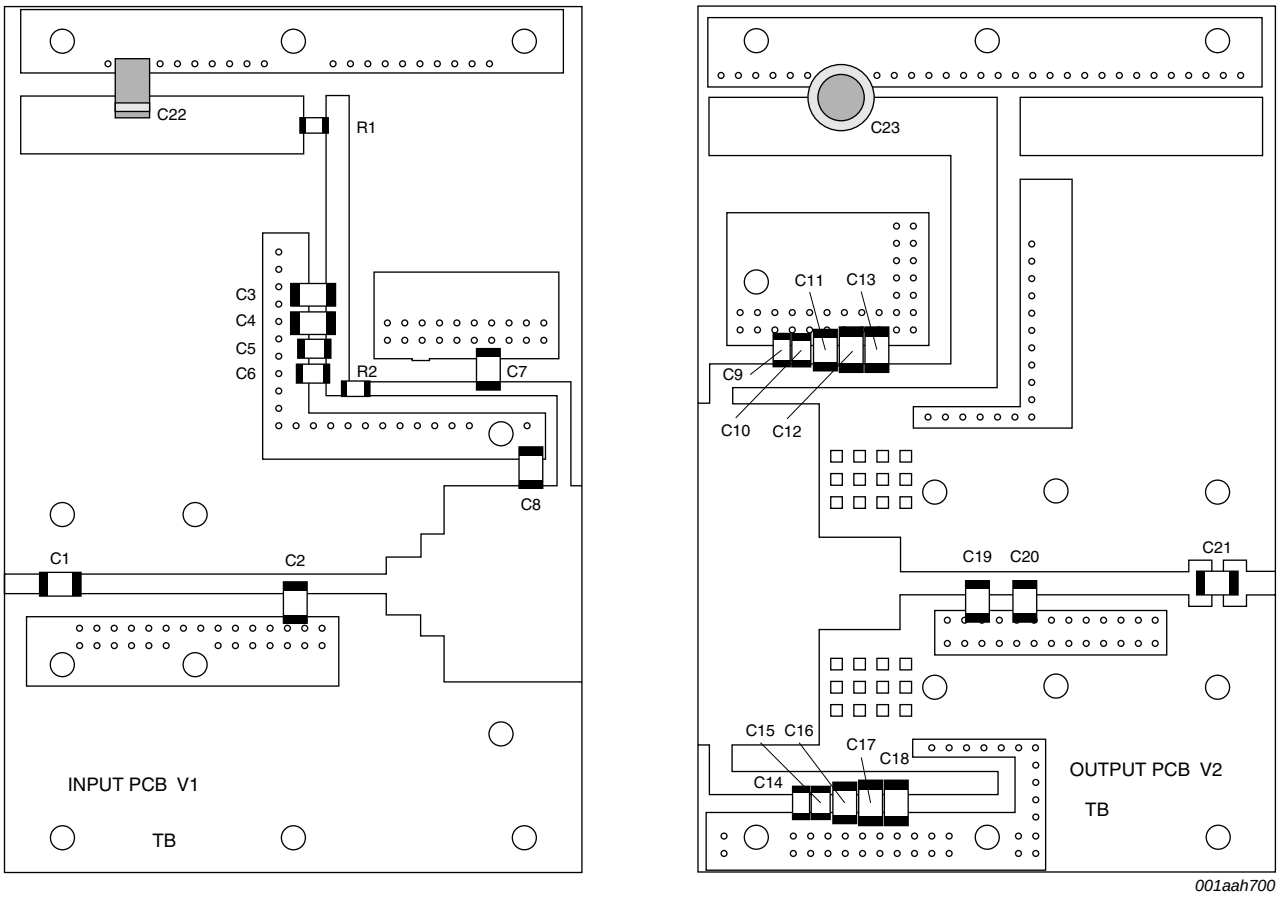
Fig 4. 2-carrier W-CDMA power gain and drain efficiency as functions of average load power; typical values



V_{DS} = 28 V; I_{Dq} = 950 mA; f = 2140 MHz (± 5 MHz); carrier spacing 10 MHz.

Fig 5. 2-carrier W-CDMA adjacent channel power ratio and third order intermodulation distortion as functions of average load power; typical values

8. Test information



The striplines are on a double copper-clad Taconic RF35 Printed-Circuit Board (PCB) with ε_r = 3.5 and thickness = 0.76 mm.

See Table 8 for list of components.

The drawing is not to scale.

Fig 6. Component layout

Table 8. List of components (see Figure 6)

Component	Description	Value		Remarks
C1	multilayer ceramic chip capacitor	5.6 pF	[1]	
C2	multilayer ceramic chip capacitor	1.0 pF	[1]	
C3, C4, C12, C13, C17, C18	multilayer ceramic chip capacitor	1.5 μF		SMD 0805; TDK or capacitor of same quality
C5, C6, C10, C15	multilayer ceramic chip capacitor	100 nF		SMD 0603; Murata or capacitor of same quality
C7	multilayer ceramic chip capacitor	1.5 pF	[1]	
C8	multilayer ceramic chip capacitor	0.6 pF	[1]	

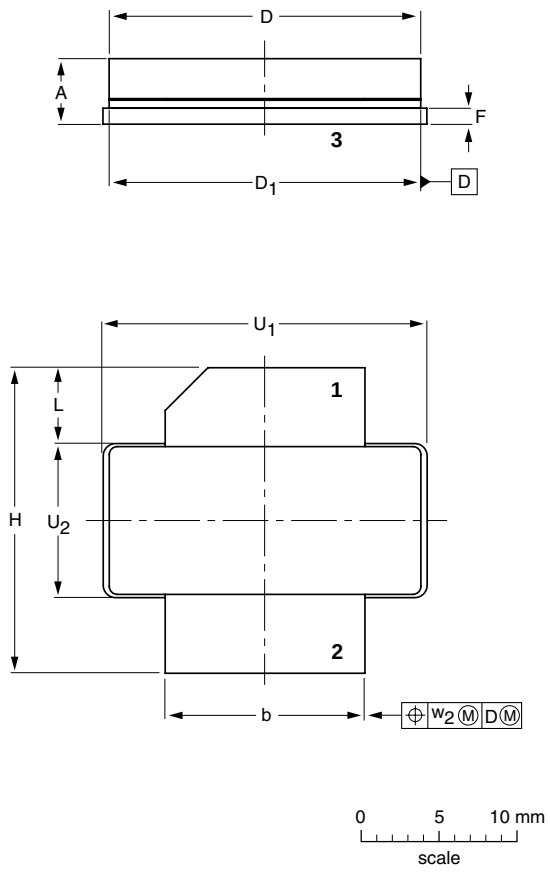
Table 8. List of components (see Figure 6) *...continued*

Component	Description	Value	Remarks
C9, C14	multilayer ceramic chip capacitor	220 nF	SMD 1206; AVX or capacitor of same quality
C11, C16	multilayer ceramic chip capacitor	10 pF [1]	
C19	multilayer ceramic chip capacitor	1.1 pF [1]	
C20	multilayer ceramic chip capacitor	0.5 pF [1]	
C21	multilayer ceramic chip capacitor	20 pF [1]	
C22	tantalum capacitor	10 μF; 35 V	
C23	electrolytic capacitor	220 μF; 35 V	
R1	SMD resistor	3.6 Ω	
R2	SMD resistor	5.1 Ω	

[1] American Technical Ceramics type 100B or capacitor of same quality.

9. Package outline

Earless flanged LDMOST ceramic package; 2 leads **SOT502B**



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	c	D	D_1	E	E_1	F	H	L	Q	U_1	U_2	w_2
mm	4.72 3.43	12.83 12.57	0.15 0.08	20.02 19.61	19.96 19.66	9.50 9.30	9.53 9.25	1.14 0.89	19.94 18.92	5.33 4.32	1.70 1.45	20.70 20.45	9.91 9.65	0.25
inches	0.186 0.135	0.505 0.495	0.006 0.003	0.788 0.772	0.786 0.774	0.374 0.366	0.375 0.364	0.045 0.035	0.785 0.745	0.210 0.170	0.067 0.057	0.815 0.805	0.390 0.380	0.010

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT502B						~~03-01-10~~ 07-05-09

Fig 7. Package outline SOT502B

10. Abbreviations

Table 9. Abbreviations

Acronym	Description
3GPP	Third Generation Partnership Project
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
DPCH	Dedicated Physical CHannel
LDMOS	Laterally Diffused Metal Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
PAR	Peak-to-Average power Ratio
PDPCH	transmission Power of the Dedicated Physical CHannel
RF	Radio Frequency
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

11. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF6G22LS-100_2	20100331	Product data sheet	-	BLF6G22LS-100_1
Modifications:	• Table 7: Updated several values			
BLF6G22LS-100_1	20080218	Preliminary data sheet	-	-

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12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

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14. Contents

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